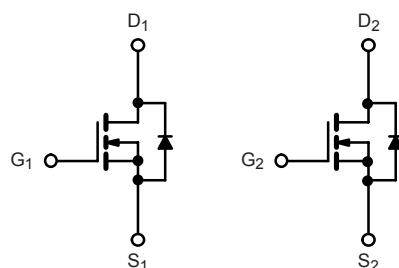
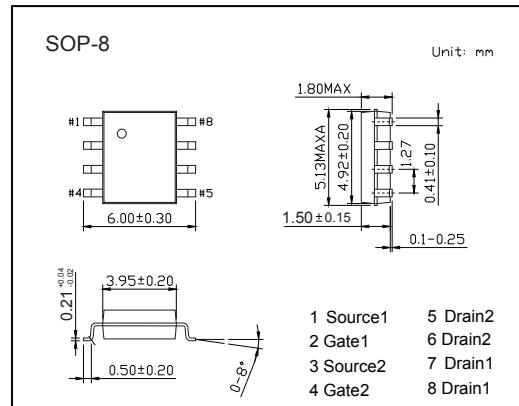


Dual N-Channel MOSFET

SI4946DY-HF (KI4946DY-HF)

■ Features

- $V_{DS} (V) = 60V$
- $I_D = 6.5 A$ ($V_{GS} = 10V$)
- $R_{DS(ON)} < 41m\Omega$ ($V_{GS} = 10V$)
- $R_{DS(ON)} < 52m\Omega$ ($V_{GS} = 4.5V$)
- 175 °C Maximum Junction Temperature
- Pb-Free Package May be Available. The G-Suffix Denotes a Pb-Free Lead Finish



■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current	I_D	6.5	A
		5.5	
		5.3	
		4.4	
Pulsed Drain Current	I_{DM}	30	
Avalanche Current	I_{AS}	12	
Single-Pulse Avalanche Energy	E_{AS}	7.2	mJ
Power Dissipation	P_D	3.7	W
		2.6	
		2.4	
		1.7	
Thermal Resistance.Junction- to-Ambient	R_{thJA}	62.5	°C/W
Thermal Resistance.Junction- to-Case	R_{thJC}	41	
Junction Temperature	T_J	150	°C
Storage Temperature Range	T_{stg}	-55 to 150	

Dual N-Channel MOSFET

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■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V_{DSS}	$I_D=250 \mu\text{A}, V_{GS}=0\text{V}$	60			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=60\text{V}, V_{GS}=0\text{V}$			1	μA
		$V_{DS}=60\text{V}, V_{GS}=0\text{V}, T_J=55^\circ\text{C}$			10	
Gate-Body Leakage Current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250 \mu\text{A}$	1		3	V
Static Drain-Source On-Resistance	$R_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=5.3\text{A}$ (Note.1)			41	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=4.7\text{A}$ (Note.1)			52	
On State Drain Current	$I_{D(\text{ON})}$	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$ (Note.1)	30			A
Forward Transconductance	g_{FS}	$V_{DS}=15\text{V}, I_D=5.3\text{A}$ (Note.1)		24		S
Input Capacitance	C_{iss}			840		pF
Output Capacitance	C_{oss}	$V_{GS}=0\text{V}, V_{DS}=30\text{V}, f=1\text{MHz}$		71		
Reverse Transfer Capacitance	C_{rss}			44		
Gate Resistance	R_g	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$	3.1		9.5	Ω
Total Gate Charge	Q_g	$V_{DS} = 30\text{ V}, V_{GS} = 10\text{ V}, I_D = 5.3\text{ A}$		17	25	nC
					9.2	12
Gate Source Charge	Q_{gs}	$V_{DS}=30\text{V}, V_{GS}=5\text{V}, I_D=5.3\text{A}$			3.3	
Gate Drain Charge	Q_{gd}				3.7	
Turn-On Delay Time	$t_{d(on)}$				30	ns
Turn-On Rise Time	t_r	$V_{DD} = 30\text{ V}, R_L = 6.8\ \Omega$ $I_D \approx 4.4\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$			180	
Turn-Off Delay Time	$t_{d(off)}$				30	
Turn-Off Fall Time	t_f				45	
Turn-On Delay Time	$t_{d(on)}$				15	
Turn-On Rise Time	t_r	$V_{DD} = 30\text{ V}, R_L = 6.8\ \Omega$ $I_D \approx 4.4\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$			20	nC
Turn-Off Delay Time	$t_{d(off)}$				40	
Turn-Off Fall Time	t_f				15	
Body Diode Reverse Recovery Time	t_{rr}				50	
Body Diode Reverse Recovery Charge	Q_{rr}	$I_F = 4.4\text{ A}, dI/dt = 100\text{A}/\mu\text{s}, T_J = 25^\circ\text{C}$			50	ns
Reverse Recovery Fall Time	t_a				18	
Reverse Recovery Rise Time	t_b				7	
Maximum Body-Diode Continuous Current	I_S	$T_c = 25^\circ\text{C}$			3.1	A
Pulse Diode Forward Current	I_{SM}	(Note.1)			30	
Diode Forward Voltage	V_{SD}	$I_S=2\text{A}, V_{GS}=0\text{V}$ (Note.1)			1.2	V

Note.1: Pulse test; pulse width $\leq 300\text{ us}$, duty cycle $\leq 2\%$.

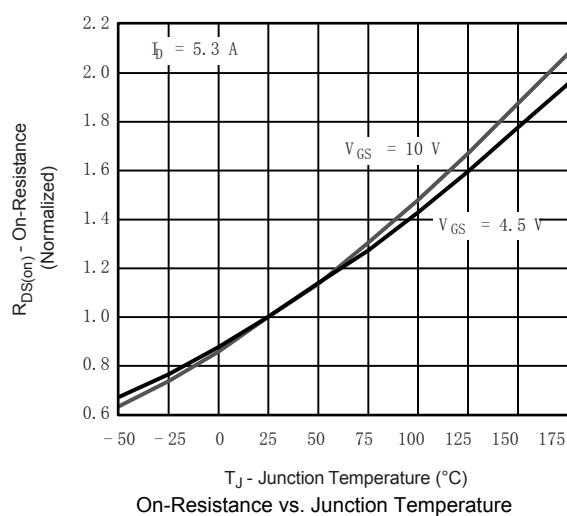
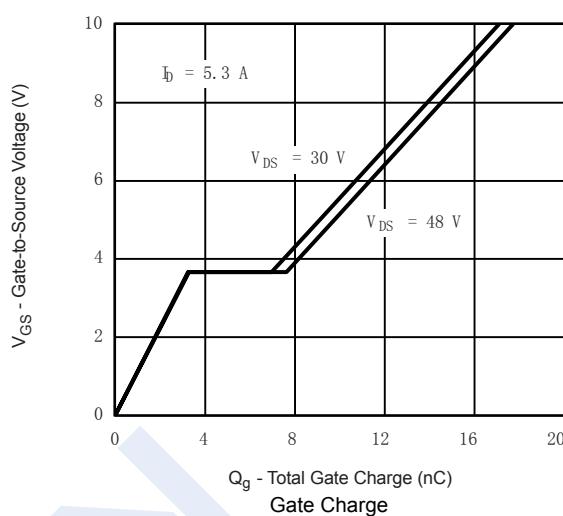
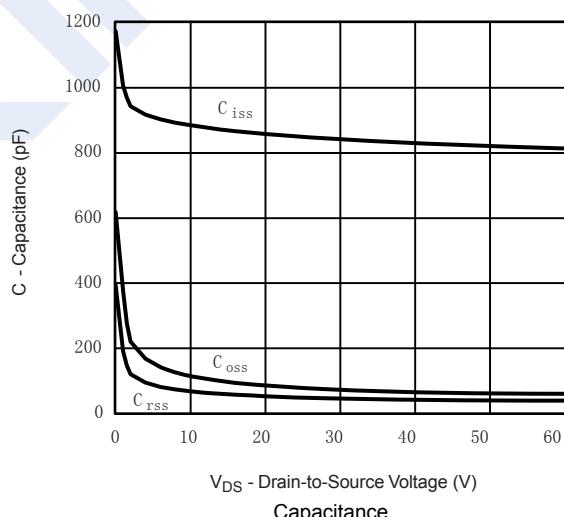
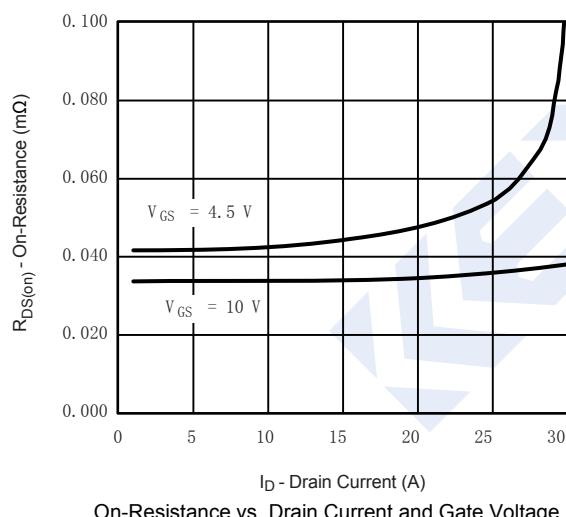
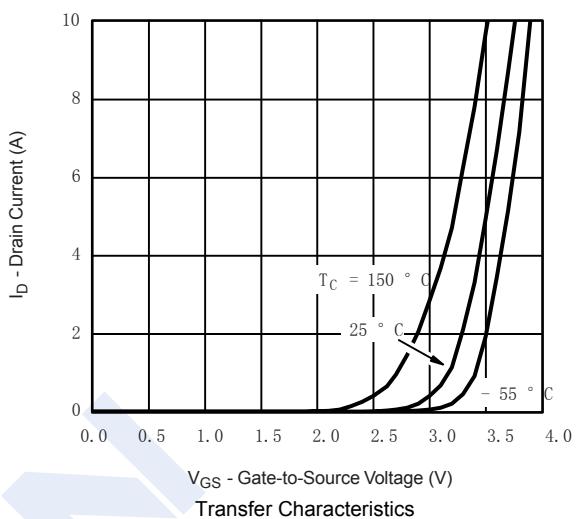
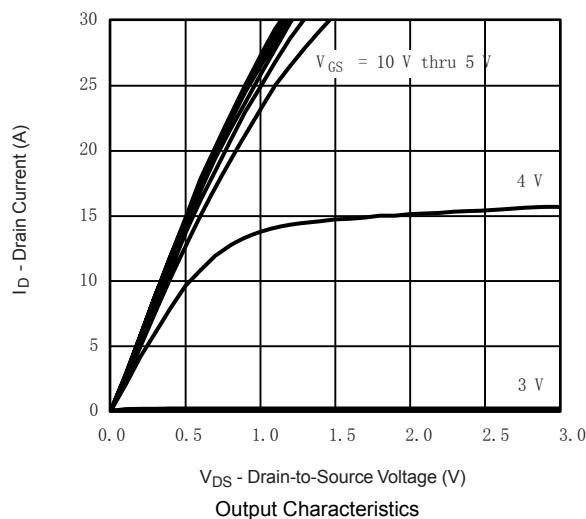
■ Marking

Marking	4946
	KA**** F

Dual N-Channel MOSFET

SI4946DY-HF (KI4946DY-HF)

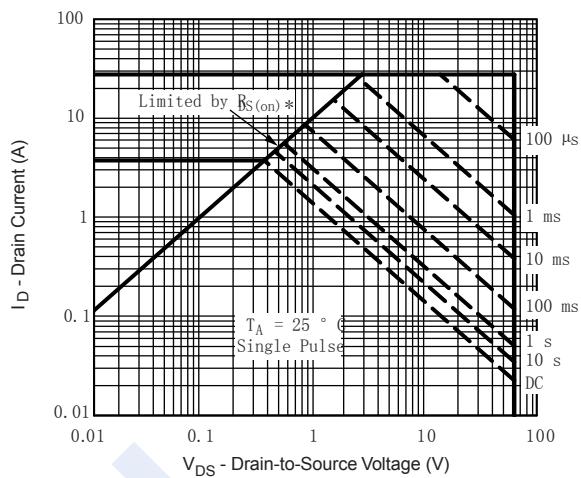
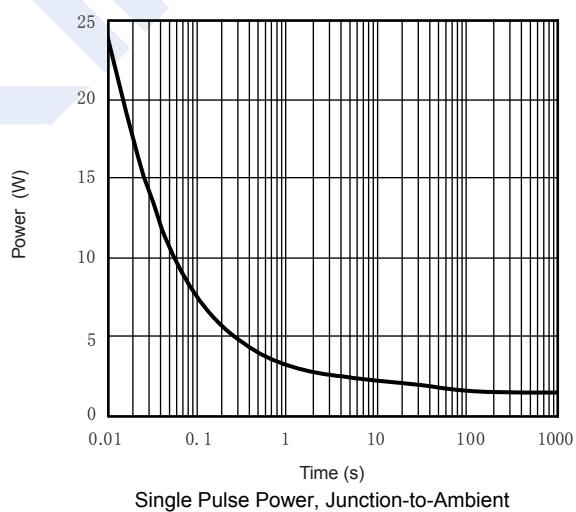
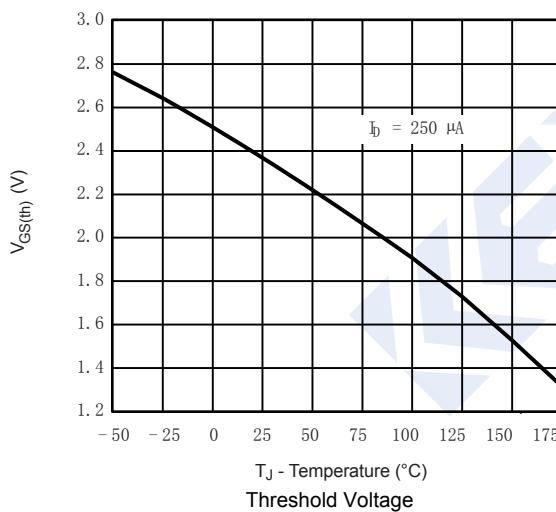
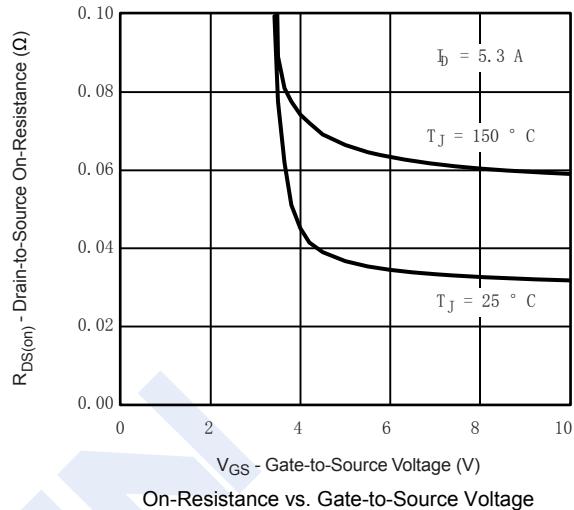
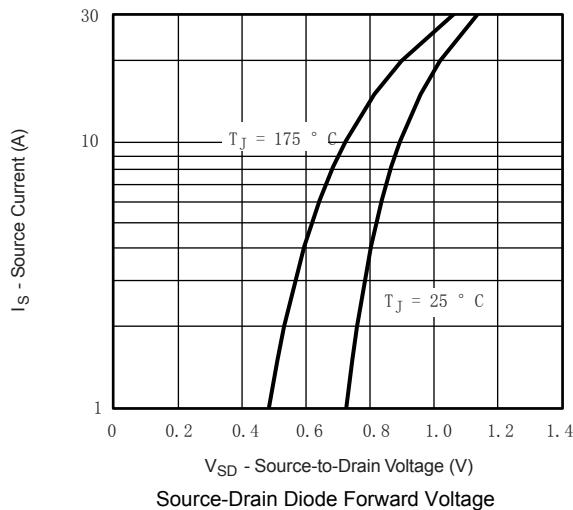
■ Typical Characteristics



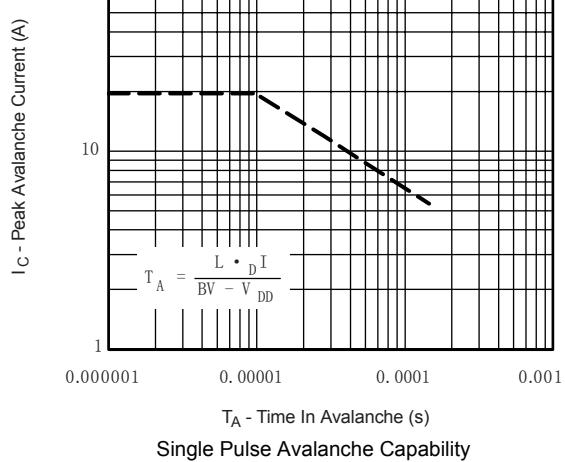
Dual N-Channel MOSFET

SI4946DY-HF (KI4946DY-HF)

■ Typical Characteristics



* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified
Safe Operating Area, Junction-to-Ambient



Dual N-Channel MOSFET

SI4946DY-HF (KI4946DY-HF)

■ Typical Characteristics

